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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/799,362	HARRINGTON ET AL.		
Examiner	Art Unit		
Cloud K. Lee	3753		

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Class	Subdass	Date	Examiner			
137	624.11 355.19 355.16-,18 355.2	9/16/2006	CL			
251	129.04	9/16/2005	CL			
251	129.05	9/16/2006	CL			
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